## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | JAIN ET AL. | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,359,920	03-2002	Jewell et al.	372/46.01
*	В	US-5,960,018	09-1999	Jewell et al.	372/45.011
*	С	US-5,274,269	12-1993	DePuydt et al.	257/744
*	D	US-5,396,103	03-1995	Oiu et al.	257/744
*	E	US-5,943,355	08-1999	Sanaka et al.	372/45.01
*	F	US-6,147,365	11-2000	Fischer et al.	257/78
*	G	US-6,157,047	12-2000	Fujita et al.	257/51
*	Н	US-6,236,060	05-2001	Chan et al.	257/13
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р					
	ο					
	R					
	S					
	Т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	х	·

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.